

Substitute Form PTO-1449 (Modified)		U.S. Department of Commerce Patent and Trademark Office		Attorney's Docket No. 14219-0079US1	Application No. 10/526,278
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Christian Block et al.			
		Filing Date March 1, 2005	Group Art Unit 2836		

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